

वैधुतिक मापन उपयंत्र अभिकल्प संस्थान, मुंबई

INSTITUTE FOR DESIGN OF ELECTRICAL MEASURING INSTRUMENTS, MUMBAI



भारत सरकार की सोसाईटी सूक्ष्म, लघु एवं मध्यम उद्यम मंत्रालय Government of India Society Ministry of Micro, Small & Medium Enterprises

संदर्भ सं. / Ref. No.

IDEMI/PCI/2010-11

दिनांक :

28-01-2011

Date:

M/s. Siddhit Enterprises 202, Gorai Ekdant, Plot No.13, Gorai - II, Borivali (W) Mumbai - 400 091.

Attn. Mr. S.N. SAKHARE

विषय: परिक्षण रिपोर्ट Sub: **Test Report**

महोदय,

आपके उपकरणों / अवयवों पर किये हुये परिक्षण रिपोर्ट संख्या (CT/PCI/1602/2010-1)। आपको जानकारी के लिए पत्र के साथ भेंज रहे हैं। यदि आपको परिक्षीत मदों पर स्पष्टीकरण की कोई आवश्यकता हो तो, कृपया परिक्षण रिपोर्ट जारी करने वाले प्राधिकारी को हमारे संदर्भ संख्या और तारीख का उल्लेख करते हुए, रिपोर्ट प्राप्त होने पर चार सप्ताह के अन्दर सम्पर्क करें अथवा लिखें। हम इस पत्र के साथ फीड बॅक फॉर्म भेज रहे हैं। कृपया उसे भरके प्रधाननिदेशक, वैमाउअसं को भेजे।

धन्यवाद!

भवदीय

संलग्न पत्रानुसार

प्रधान निदेशक

Dear Sir,

Test Report No. (CT/PCI/1602/2010-11) / on your instruments/ Components/ Equipments are / is enclosed herewith for your information. If you need any clarification on Test Report, please write/contact Test Report issuing officer quoting our reference and date within 4 weeks from the date of receipt of this report. We are also enclosing here with feed back form. Kindly fill up and send to the Principal Director of IDEMI Thanking you,

Encl. As above

PRINCIPAL DIRECTOR



the

Swatantryaveer Tatya Tope Marg, Chunabhatti, Sion P.o. **Mumbai** - 400 022. (M.S)

Phone: (022) - 2405 0301/2/3/4 Fax: (022) - 2405 0016.

• Website : www.idemi.org / msmetdcmumbai.org • Email : idemi@vsnl.net, idemi@mtnl.net.in

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IABL ACCREDITED LAB

FF-LAB-02



सुक्ष्म, लघु एवं मध्यम MICRO, SMALL & MEDIUM ENTERPRISES MSME - TECHNOLOGY DEVELOPMENT CENTRE.

TEST REPORT



Calibration Field

: Electrical Testing

Accreditation Valid up to: 27/06/2012

Work Order No.

: WO / FLL / 073/2010-11

Date

: 27 - 01 - 2011

NABL Accreditation No: T - 1358

Certificate No. CT / PCI / 1602 /2010-11

Date of Testing: 28/01/2011

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Test item : JUNCTION BOX (PROBE DRIVER HOUSING) IP 55

Tested for: M/s. Siddhit Enterprises

202, Gorai Ekdant, Plot No. 13, Gorai - II,

Borivali (W)

Mumbai - 400 091.

Tested at : IDEMI Mumbai - 22

Specification of Item under Test		Specification of Standards/ Equipment used
Manufacturer Condition of Item	: SIDDHIT	1) KASCO Dust Chamber Sr.No.015108191 along with vacuum system gauge Sr. No. 00783110, Range; 500to 0mmwc
on receipt	: Good	Calibration valid up to 05/07/2011
Drawing No.	: SE - 001 & 002	2) S. S. NOZZLE. Internal diameter 6.3 mm
dentification	: Siddhit Enterprises	Along with Pressure gauge (50 mm) (make: Wika)
Size	: 250 X 100 X 150 mm	ID No. PG/FLL/JW
Serial No.	: 01	Calibration valid up to 05/07/2011
		Traceability: Standard/Equipment used for testing
		are traceable to NPL, New Delhi.
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Type of Test : IP - 55

Remarks:

1. Please refer page 2 of 3 for Test Results.

Procedure of Testing: The above mentioned item is tested as per IS 13947 (Part): 1993 IEC Pub 947-1 (1988), OP-ETL-014 & 016.

3. This certificate is valid only for Drawing Number SE - 001 & 002 & Copy of the Drawing is enclosed.

> M.K.-Charate **Technical Manager AUTHORISED SIGNATORY**

This report refers only to the particular item(s) submitted for testing. The report should not be reproduced except in all without the prior permission from the Principal Director IDEMI, Mumbai - 400 022)



A GOVERNMENT OF INDIA SOCIETY MINISTRY OF MICRO, SMALL & MEDIUM ENTERPRISES

वैध्तिक मापन उपयंत्र अभिकल्प संस्थान

Institute for Design of Electrical Measuring Instruments SWATANTRYAVEER TATYATOPE MARG, CHUNABHATTI, SION P.O. MUMBAI - 400 022. स्वातंत्र्यवीर तात्या टोपे मार्ग, चुनाभट्टी, सायन डाकघर, मुंबई - 400 022.



वैद्युतिक मापन उपयंत्र अभिकल्प संस्थान, मुंबई - ४०० ०२२.

INSTITUTE FOR DESIGN OF ELECTRICAL MEASURING INSTRUMENTS, MUMBAI - 400 022.



PROCESS CONTROL INSTRUMENTS LABORATORY

CERTIFICATE OF TESTING

Drawing No.SE - 001 & 002

Certificate No. CT/PCI/ 1602 / 2010-11

Sr.No: 01

Date of Test: 28/01/2011

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Test Result of JUNCTION BOX (PROBE DRIVER HOUSING)

1. Test for IP: 5X (Ingress of dust for enclosure of category 1)

The Test item was tested for dust ingress as per clause C7.5 of IS: 13947 (Part-1) 1993, IEC Pub 974 – (1998). for enclosure of categories 1. The above mentioned Junction Box (Probe Driver Housing) is supported inside dust chamber and pressure inside the Junction Box (Probe Driver Housing) maintained (-200mm wc) below atmospheric pressure by a vacuum pump.

Observation: The front cover of the above tested Junction Box (Probe Driver Housing) was opened for interior examination of dust entry. It was observed that no dust has entered the Junction Box (Probe Driver Housing).

• Result: Hence the JUNCTION BOX (PROBE DRIVER HOUSING)PASSED for IP 5X Test.

2. Test for IP X5 (Protection against Water Jet)

The Test Item was tested for ingress of water as per clause C8.5 of IS 13947 (Part-1)1993, IEC Pub 974 – (1998). The above Junction Box (Probe Driver Housing) was kept in normal mounting position on a turn table during the test.

Observation: The front cover of the above tested Junction Box (Probe Driver Housing) was opened for interior examination of water entry. It was observed that no water had entered inside the Junction Box (Probe Driver Housing)

Result: Hence the JUNCTION BOX (PROBE DRIVER HOUSING)PASSED for IP X5 Test.

Checked By

Tested By



